

Università di Pisa
Pre-tesi di dottorato
XXVIII ciclo

Controlled dose irradiation with pulsed beams of different ion species

Author: Lara Palla

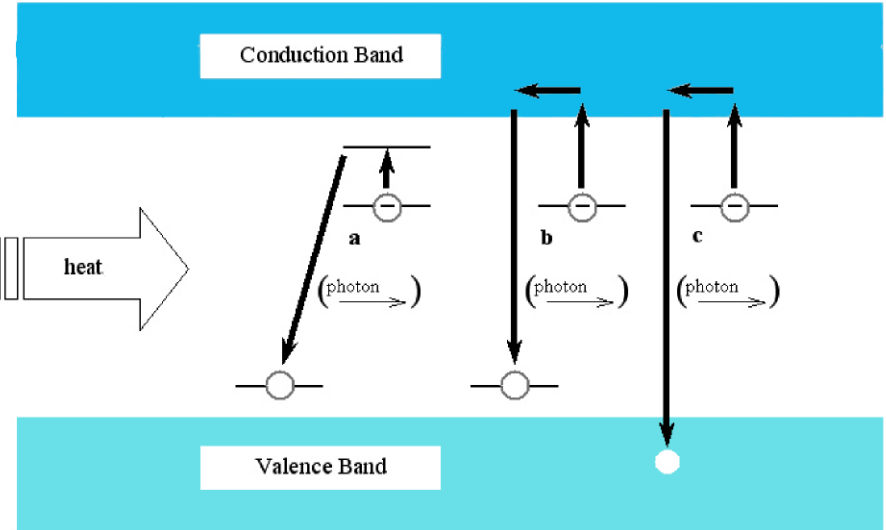
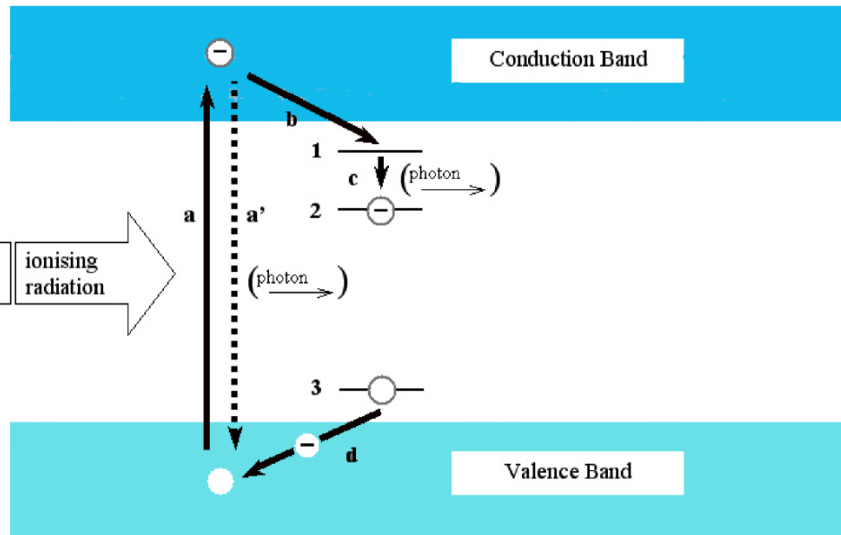
Supervisors: Prof.ssa Valeria Rosso
Dott. Francesco Taccetti

23/10/2014

Overview

- **Thermoluminescence (TL)**
- **TL dating principles**
- **The 3 MV Tandem accelerator system**
- **The pulsed beam line DEFEL**
- **Detector system setup**
- **Preliminary measurements results**

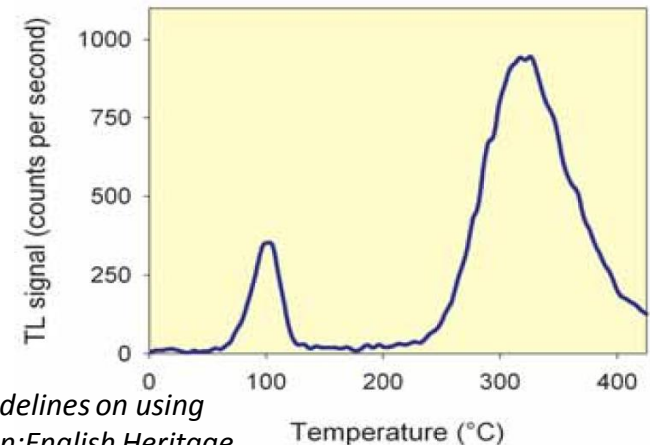
Thermoluminescence



- a) Excitation of a valence electron by ionizing radiation
- a') prompt recombination with a hole in the valence band
- b,c) trapping in a metastable level near conduction band
- d) trapping of a hole in a localized level near the valence band

- a, b) Recombination with a hole at luminescent centre
- c) Recombination with a hole in the valence band

 Glow curve



Thermoluminescence: applications

Medical sciences, radiation dosimetry

Different kinds of dosimetric materials

LiF:Mg,Ti,
LiF:Mg,Cu,P | Tissue equivalent
Li₂B₄O₇:Mn

CaSO₄:Dy
Al₂O₃:C
CaF₂:Mn

TLDs are available in various forms:
powder, chips, rods and ribbons

Archaeology: TL dating

Natural TL materials present in clay and soil: quartzs, feldspars



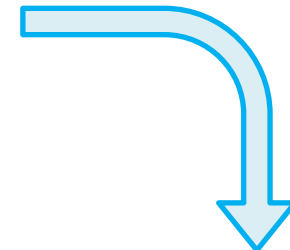
Thermoluminescence Dating

Dating of inorganic materials (ceramics, pottery, sediments, lava, meteorites...)
 Authentication of works of art

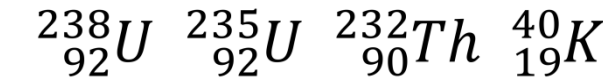
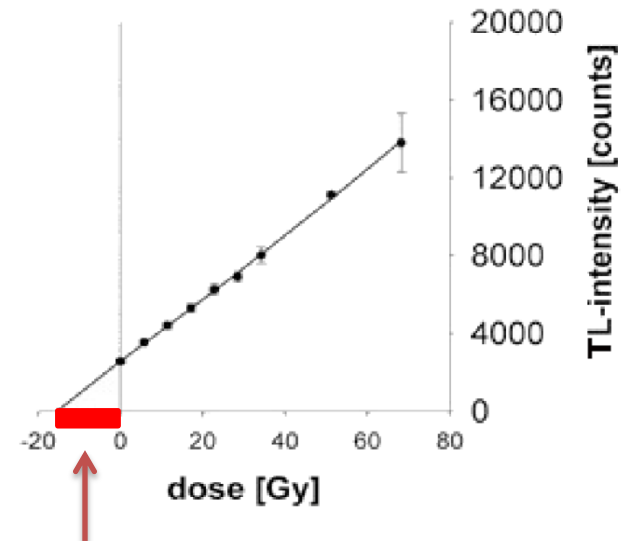
Dating range: 10-500000 years . Clock is set at time t_0 (when all traps were emptied)



$$A(y) = \frac{D_e (Gy)}{D_r (Gy/y)}$$



additive growth curve



Cosmic rays

Different contributions:

From surrounding soil

From within the sample

From space

Thermoluminescence Dating

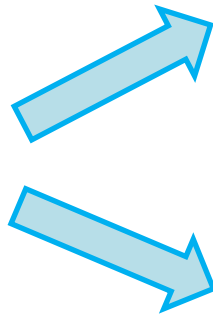
Dr evaluation

Cosmic rays
contribution



≈150 $\mu\text{Gy}/\text{year}$ (1-2 m underground)

Radioactive
nuclides
contribution



Quartz inclusion technique ($\approx 100 \mu\text{m}$ quartz grains cores)

Main contribution: β and γ radiation from soil

2
mGy/year

Fine Grain technique ($\approx 1-8 \mu\text{m}$ quartz grains)

Main contribution: α radiation from within the sample

5
mGy/year

Controlled dose irradiation

The mechanisms at the basis of TL are not yet well known

The properties of TL materials are still under study: TL efficiency for different incident particles (particular interest in α particles for TL dating), radiation damage, dose rate effects.



Sample irradiations with known doses at the 3 MV Tandem accelerator of LABEC

p, Li, C, O, ...

Energy: <1-6 MeV for protons
1-few tens of MeV for heavier ions

Dose <<1 mGy - 1000 Gy
Fluence 10^5 - 10^{11} cm⁻²

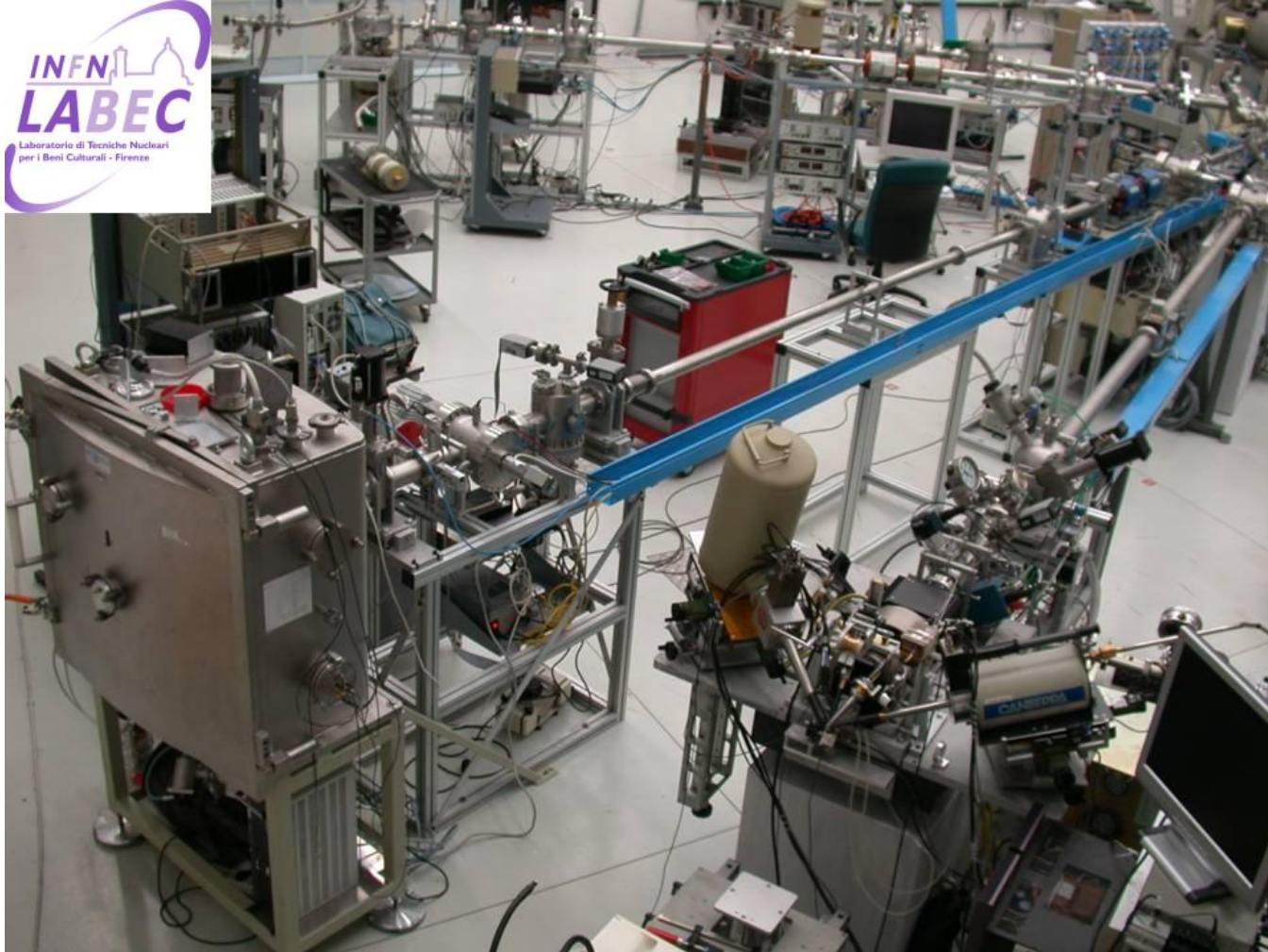
Very low beam currents

Example: quartz sample of 1 cm² → 2 Gy with 5 MeV α particles → 10^7 cm⁻² → 1 pA for 1s



Use of pulsed beams

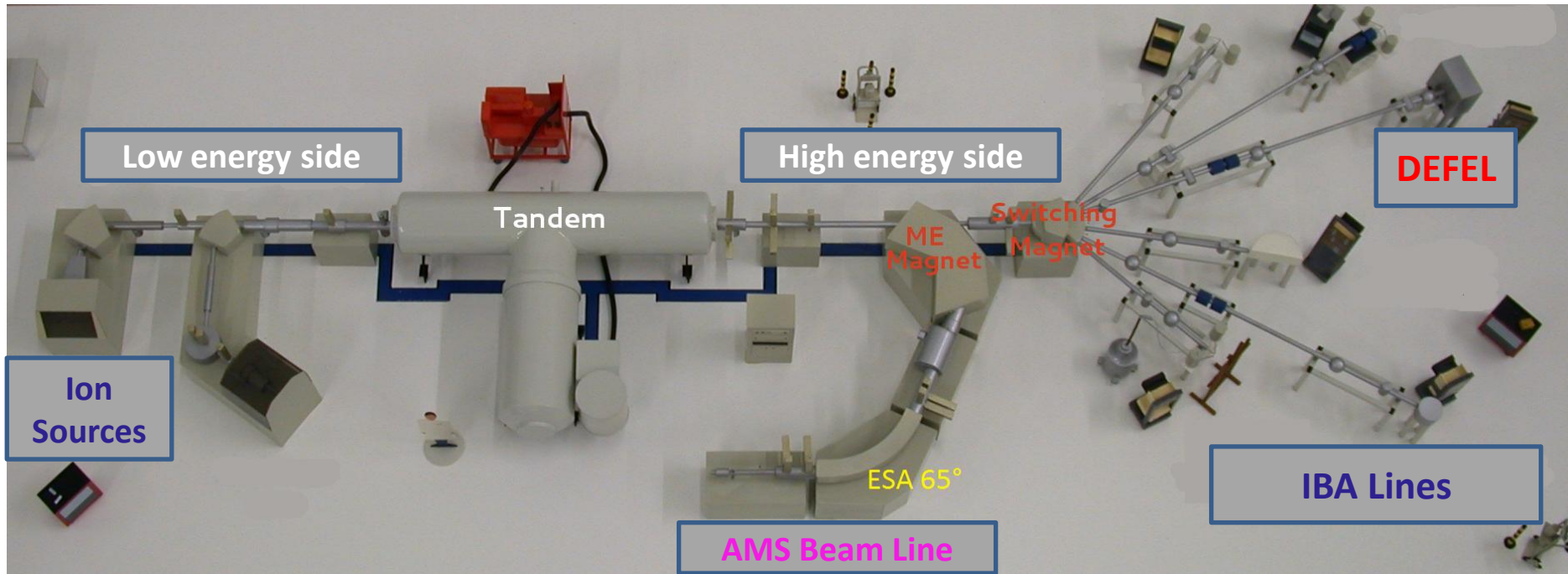
The pulsed beam line DEFEL



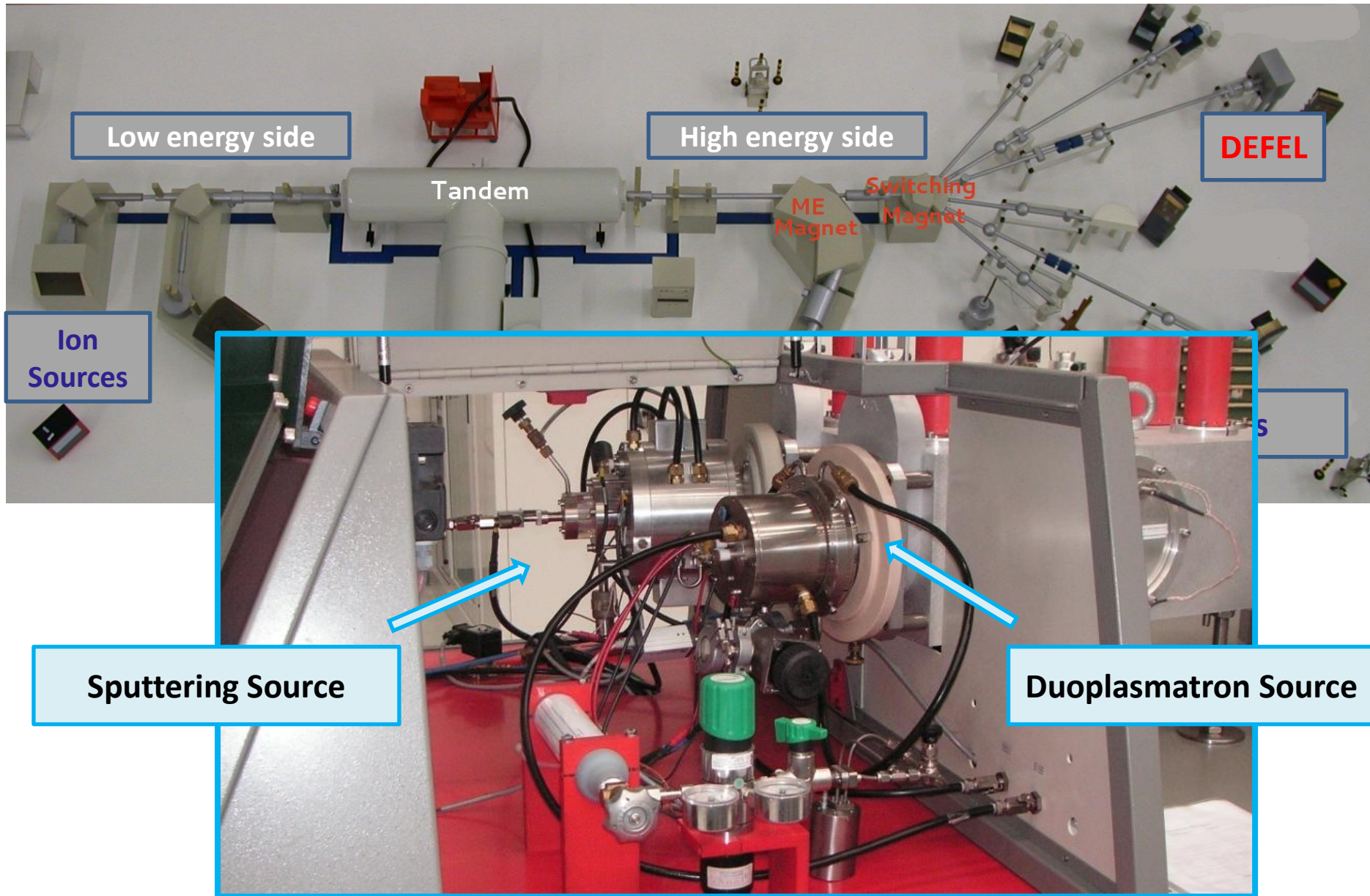
**Bunch multiplicity:
1 – few hundreds**

**Bunch frequency:
single pulse-1 kHz**

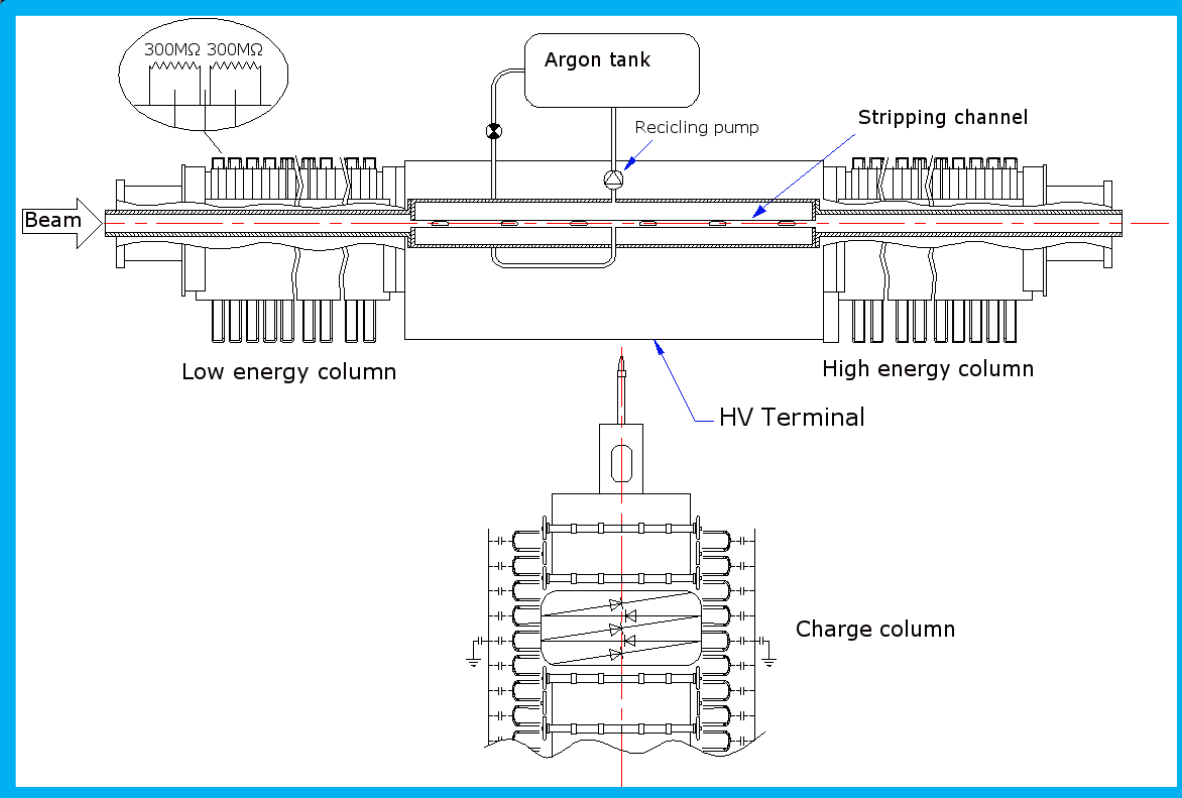
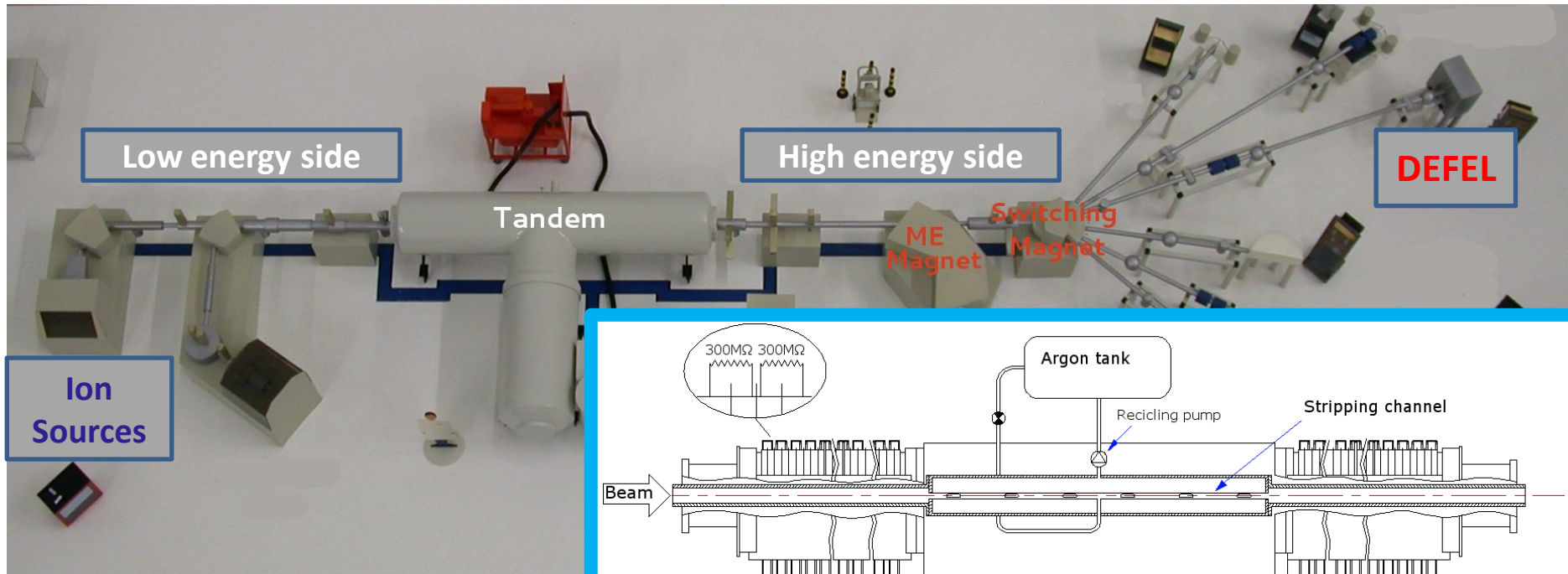
The accelerator system



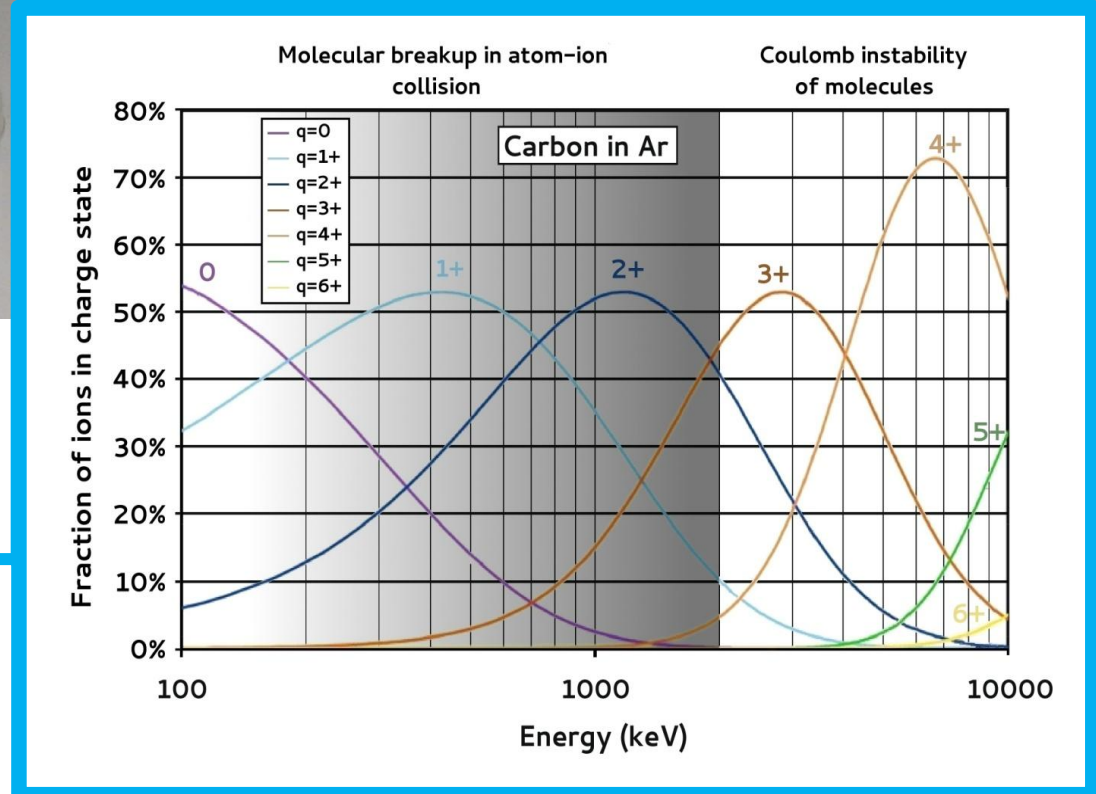
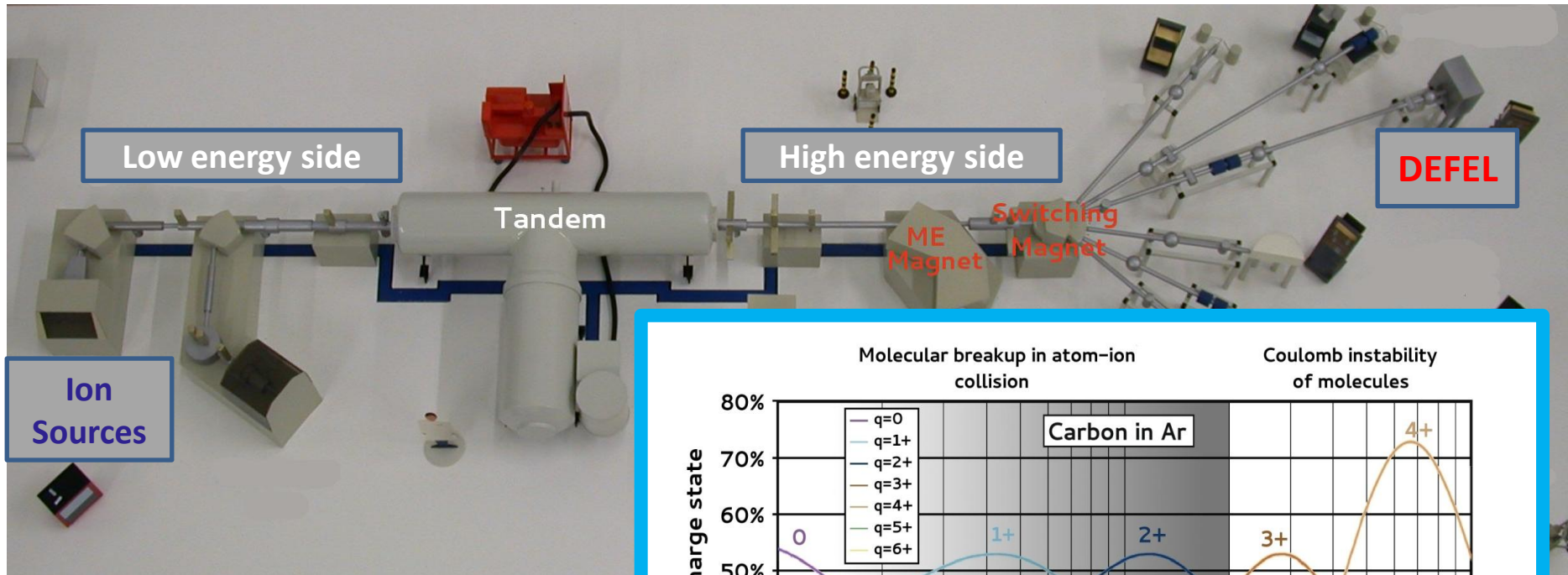
The accelerator system: ion sources



The accelerator system: the acceleration

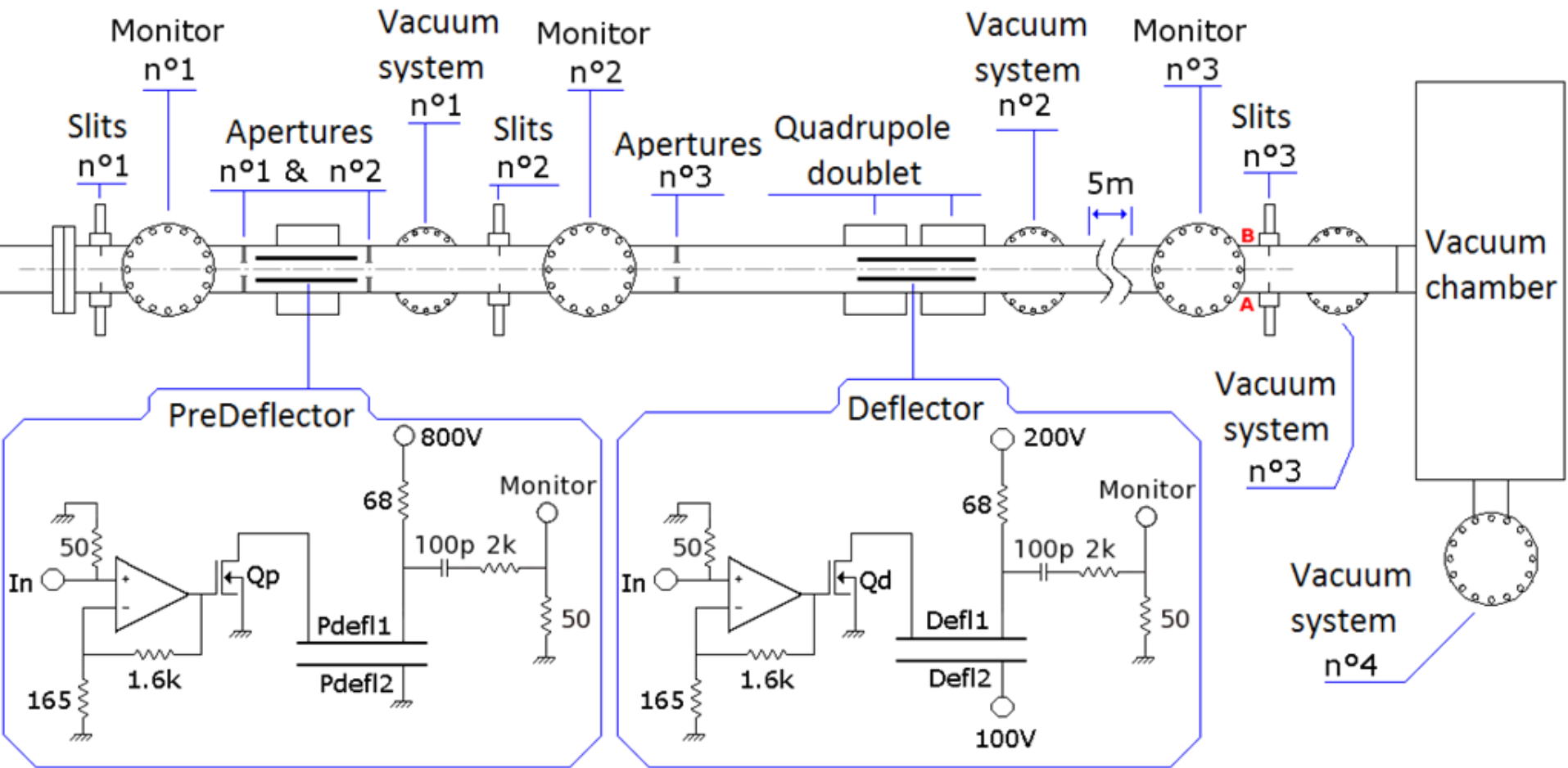


The accelerator system: the acceleration

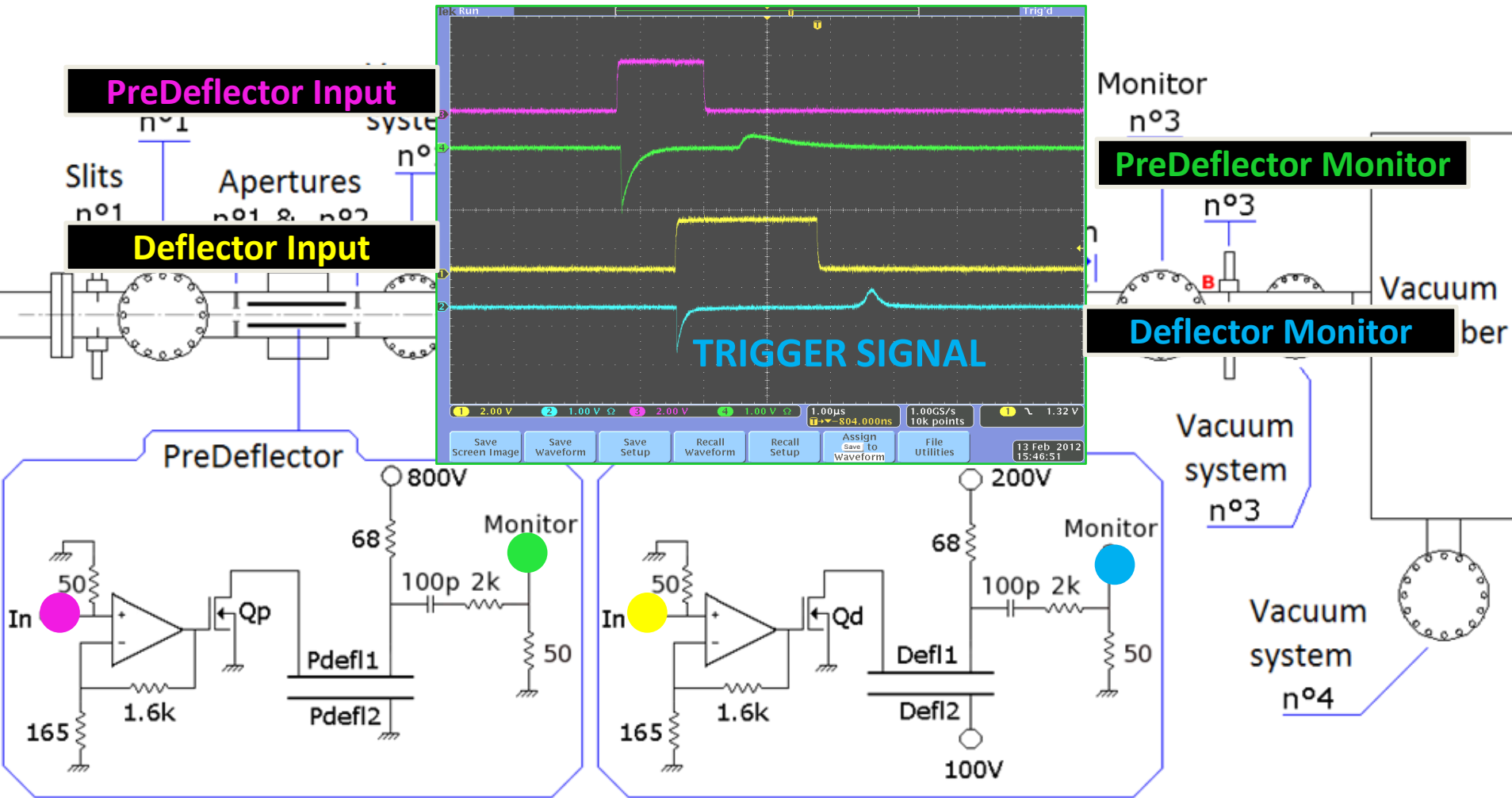


$$E_f = (E_i + qV_T) \frac{m_f}{m_i} + QV_T$$

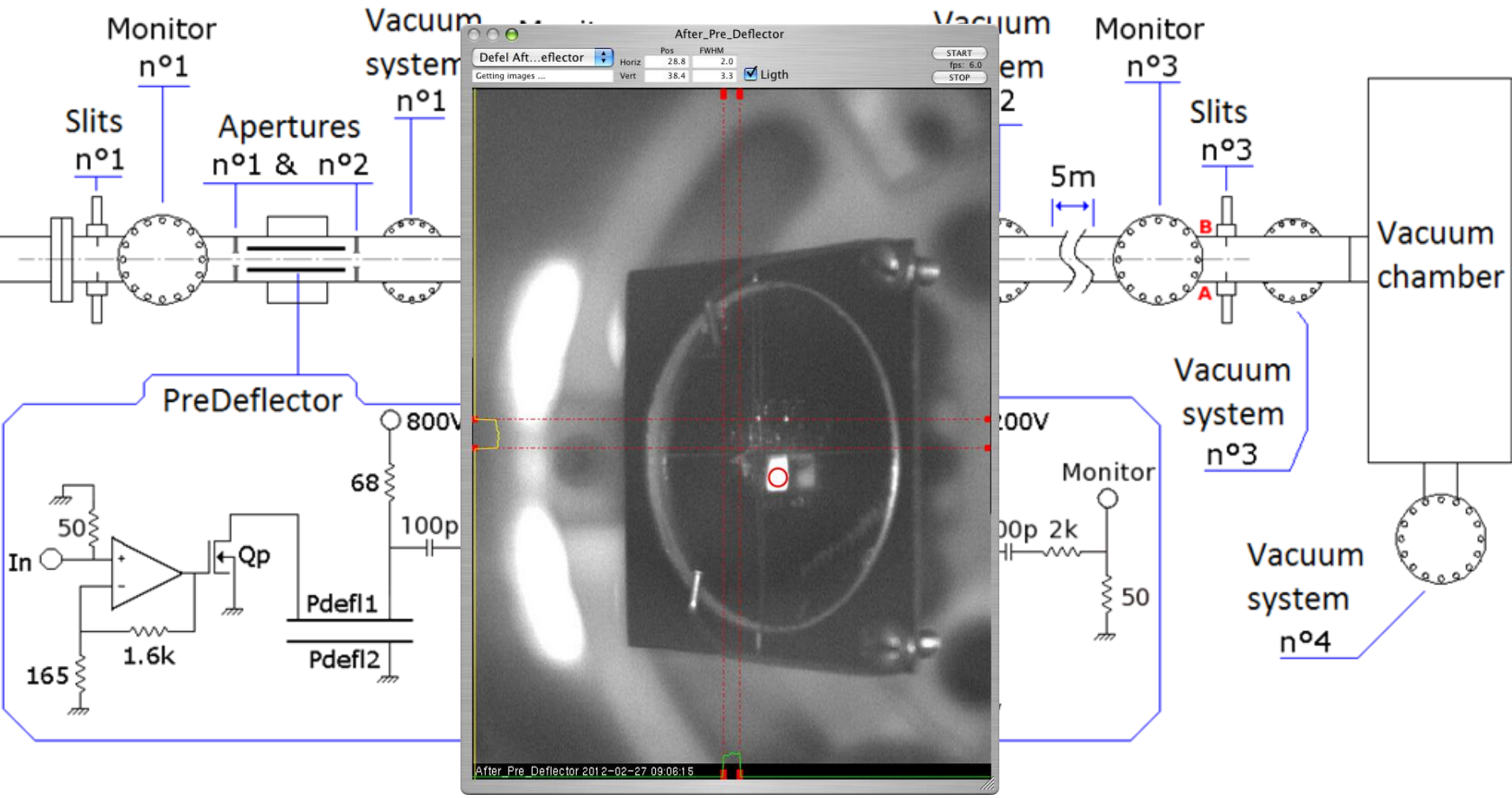
DEFEL: the creation of ion bunches



DEFEL: the creation of ion bunches



DEFEL: the creation of ion bunches

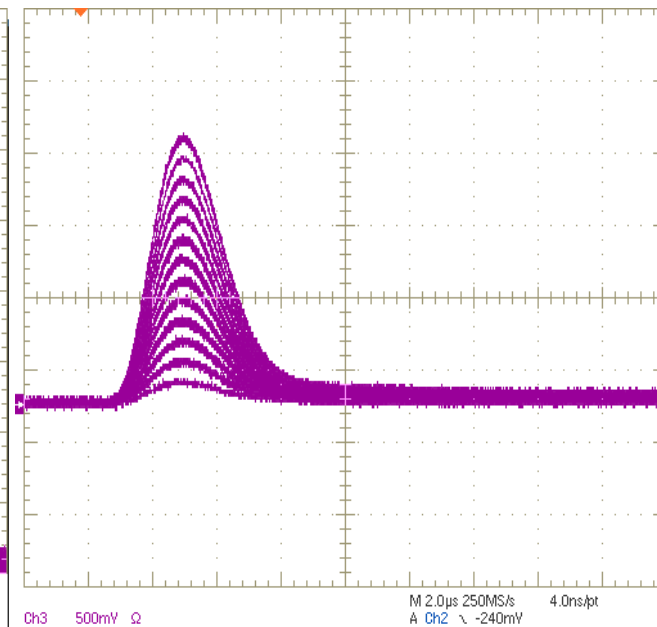
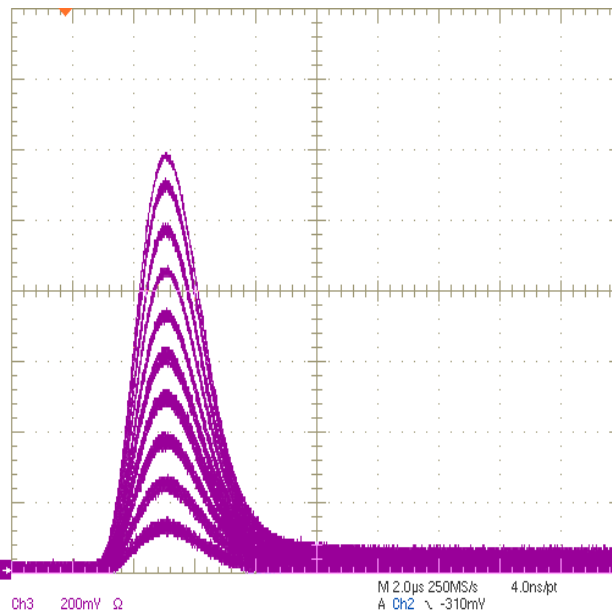
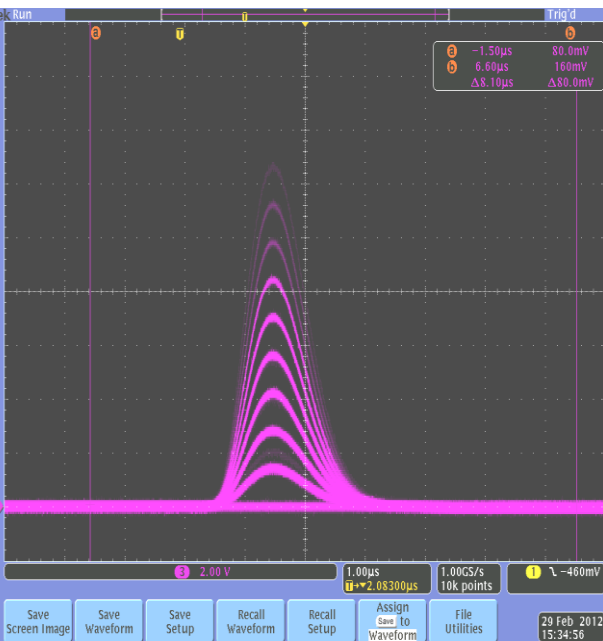


DFEL: bunch characteristics

The bunch multiplicity follows a Poisson statistics

mean value μ depends on

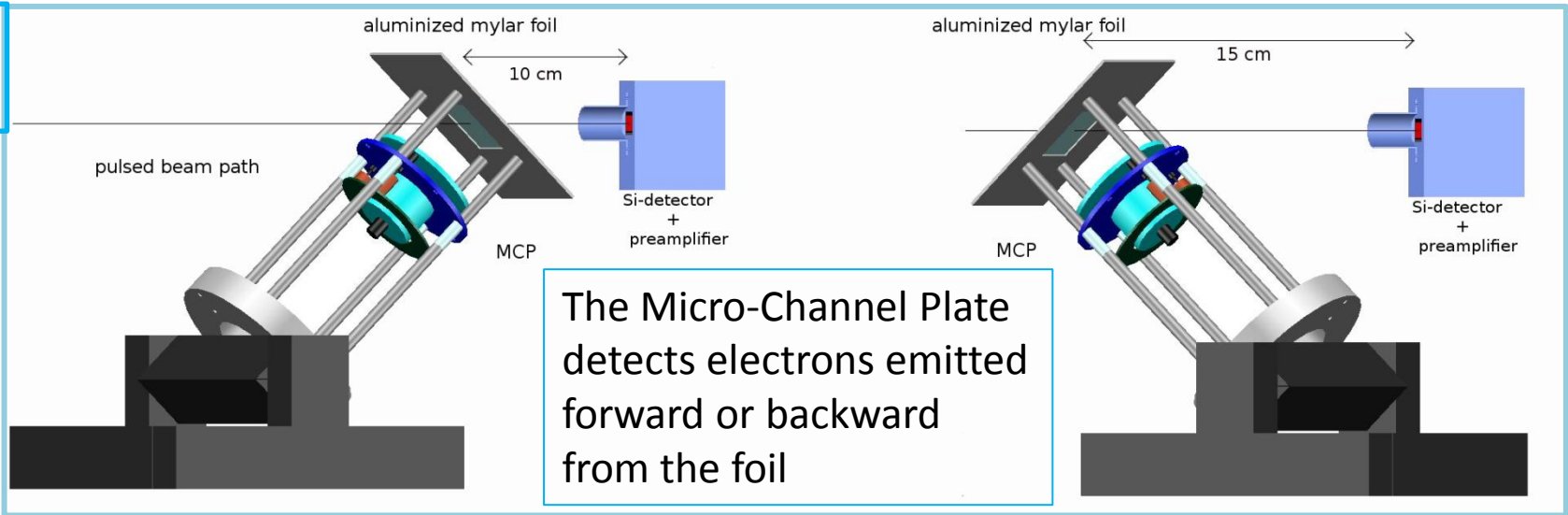
- Initial beam current intensity
- Final apertures width
- Beam spot dimensions
- Deflecting fields intensity



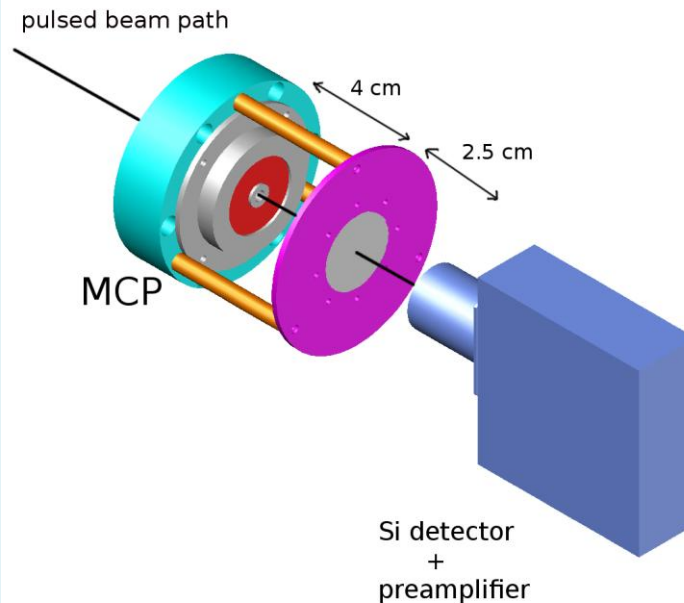
The detector system: configurations

Counting of the ions inside the DEFEL bunches that hit the sample

1



2



The detector system: the MCP



Model F9892-12

Effective area diam. 4 cm
Channel diam. 6 μm
PHR 150 %



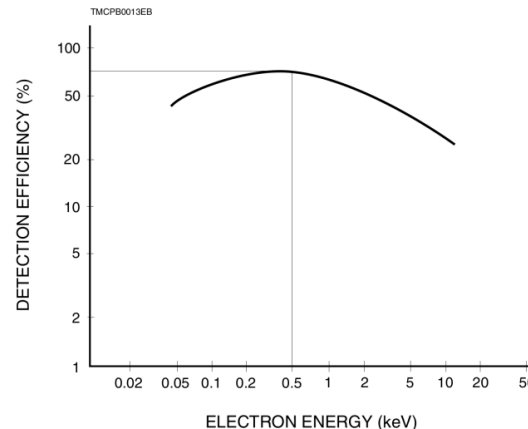
Model F4655-12

Effective area diam. 1.5 cm
Channel diam. 12 μm
PHR 50 %

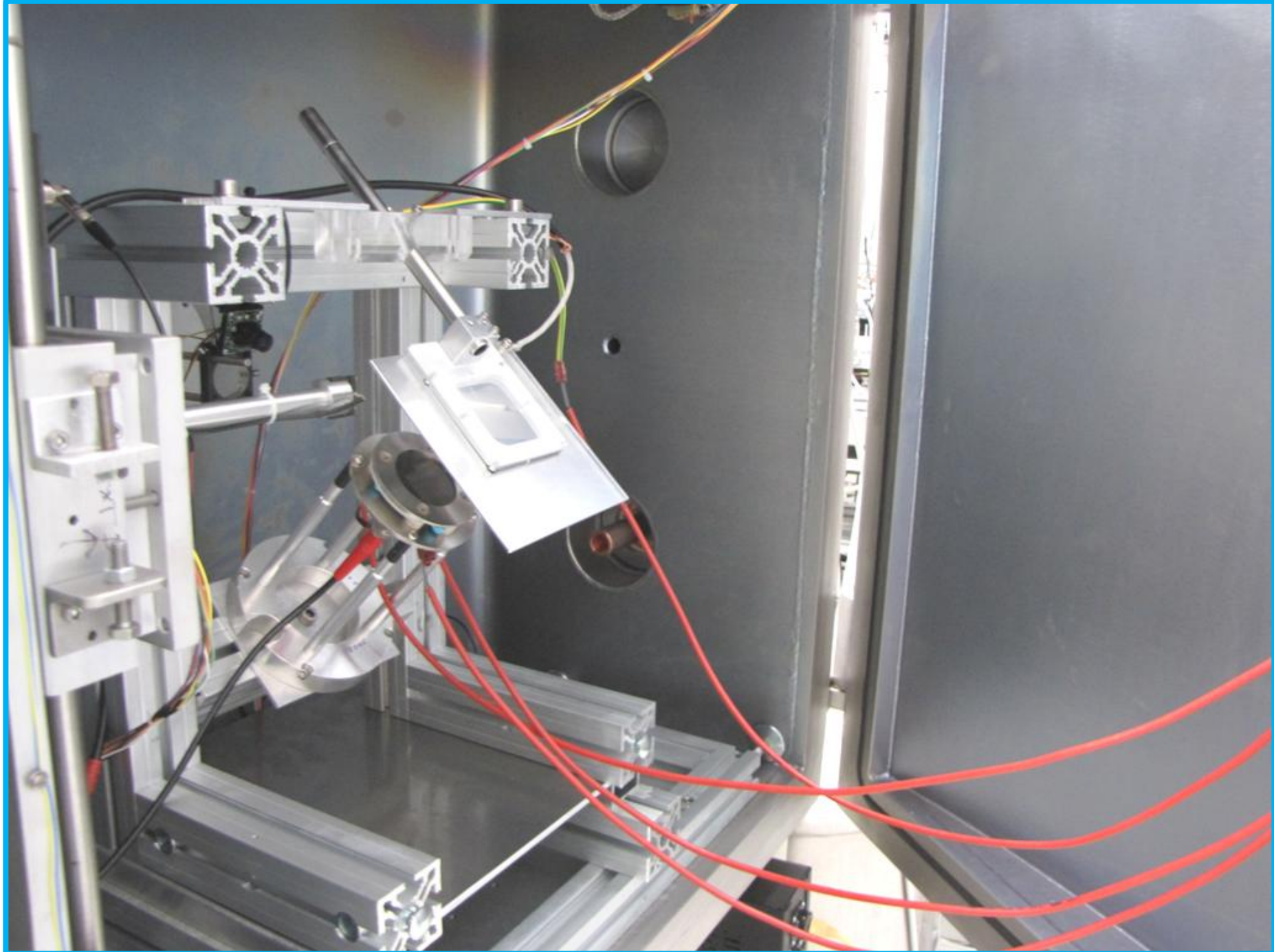


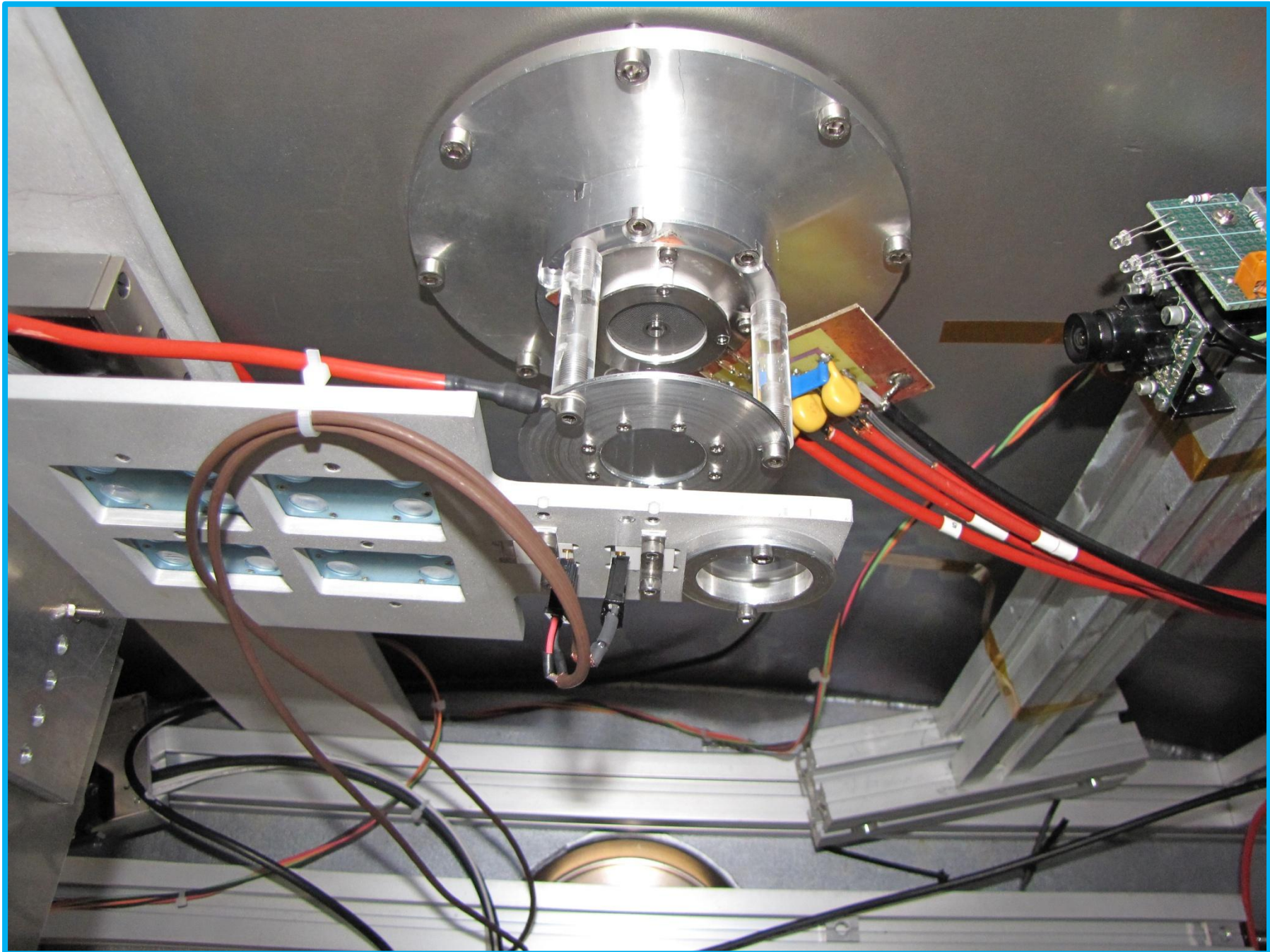
Model F2223-21SH

Effective area diam. 3 cm
Channel diam. 12 μm
Hole diam. 4 mm
PHR 150 %



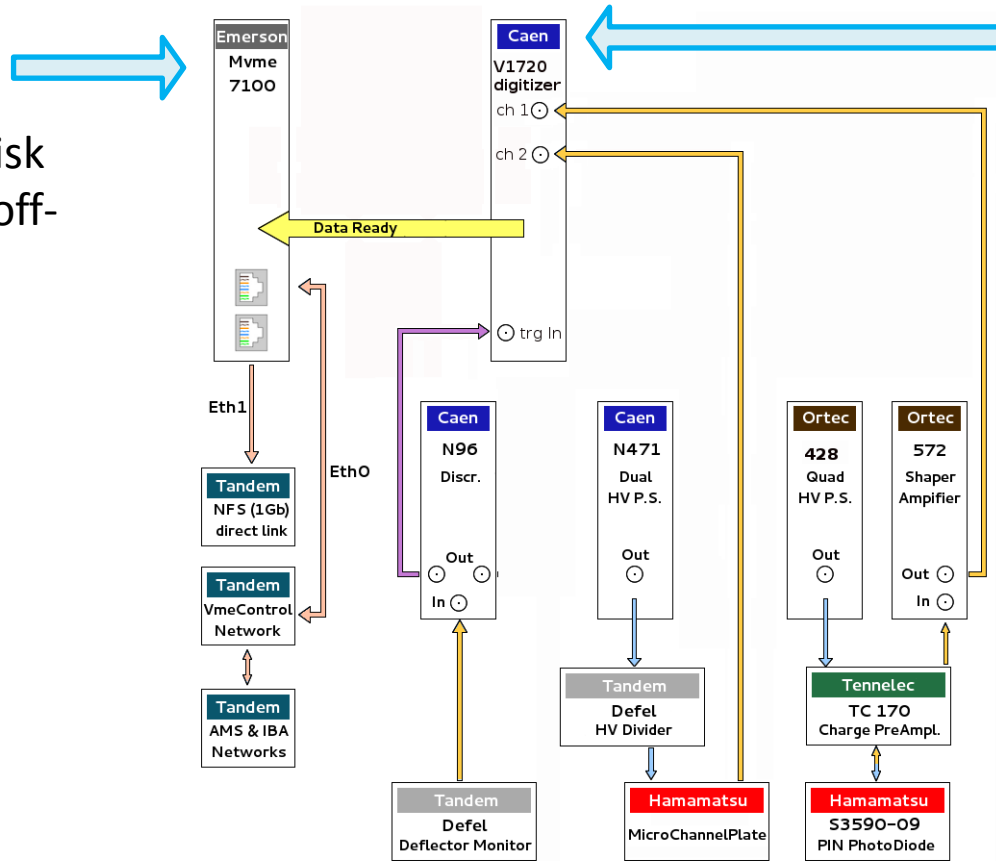
Detection efficiency for electrons



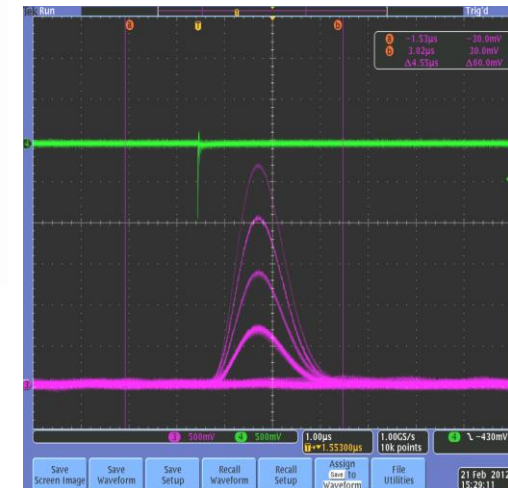


The detector system: electronics

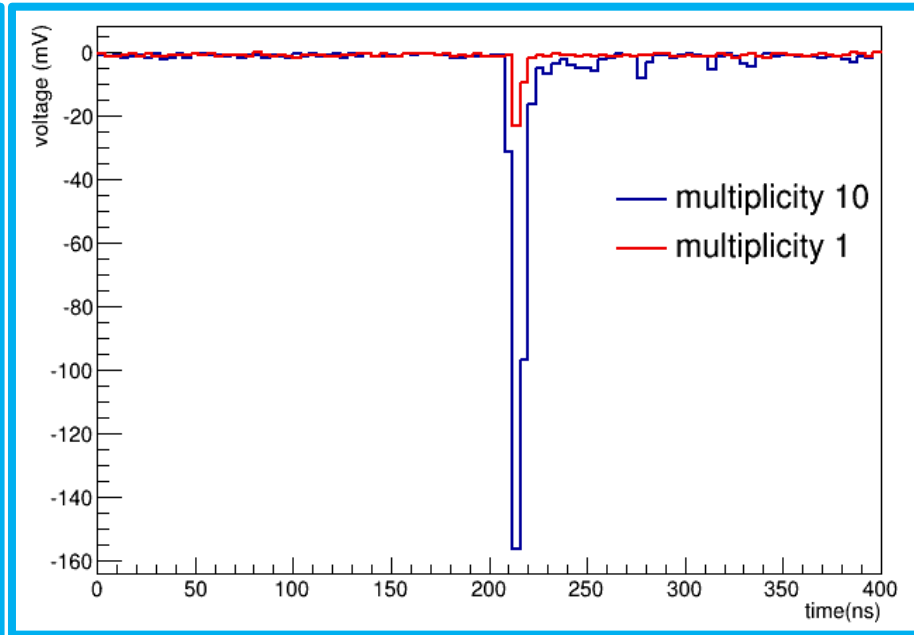
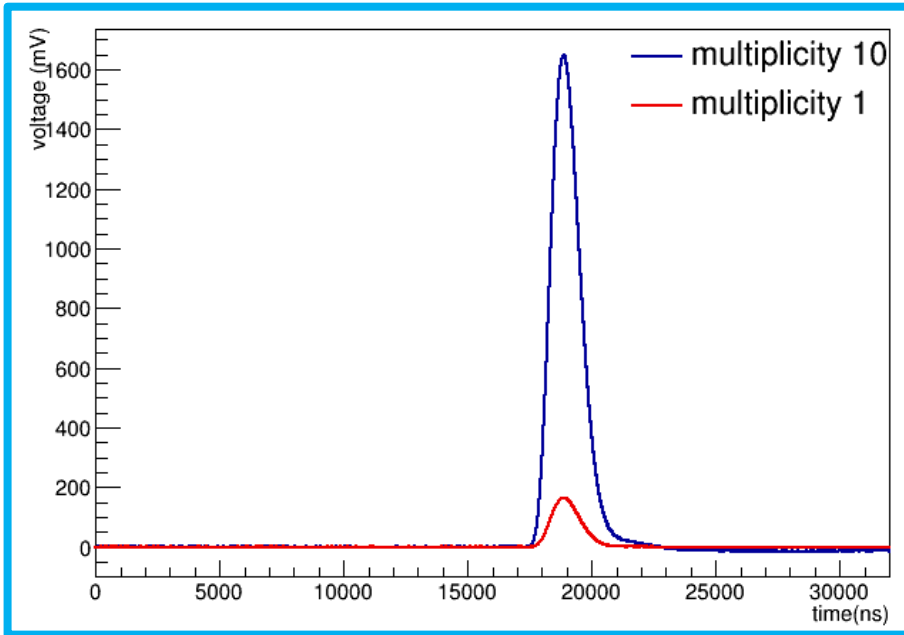
Data stored on disk
(binary files) for off-
line analysis



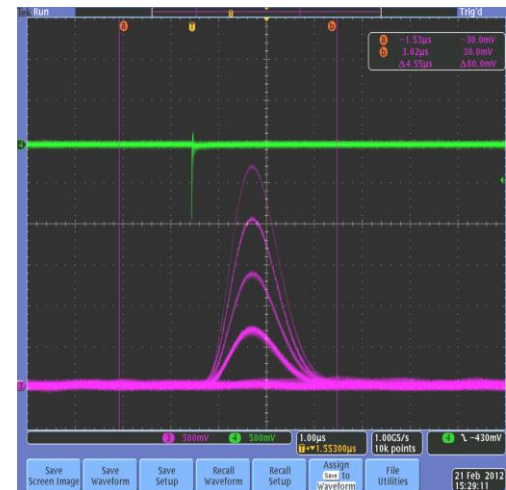
12 bit resolution
250 MS/s
Input range 2Vpp max



The detector system: electronics

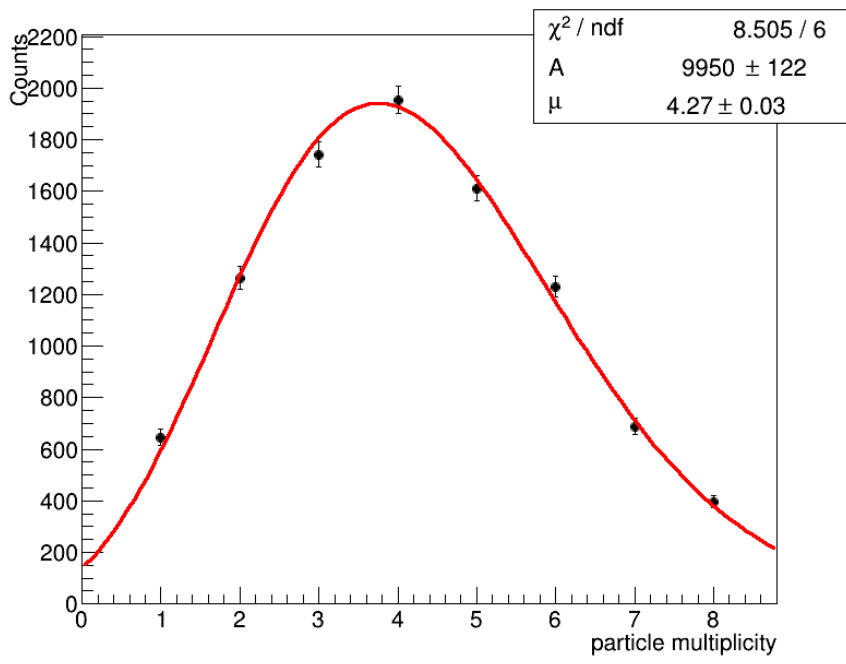
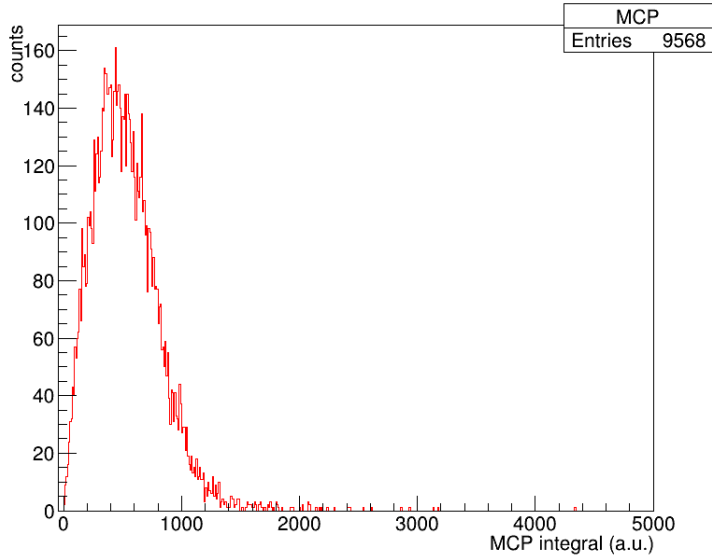
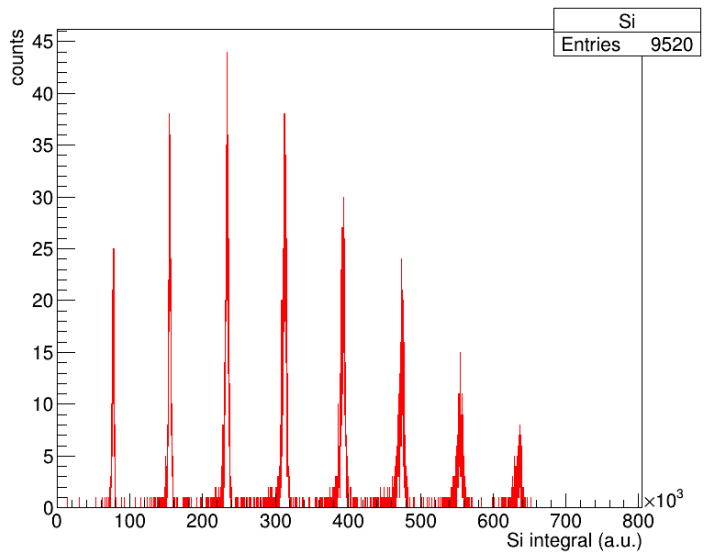


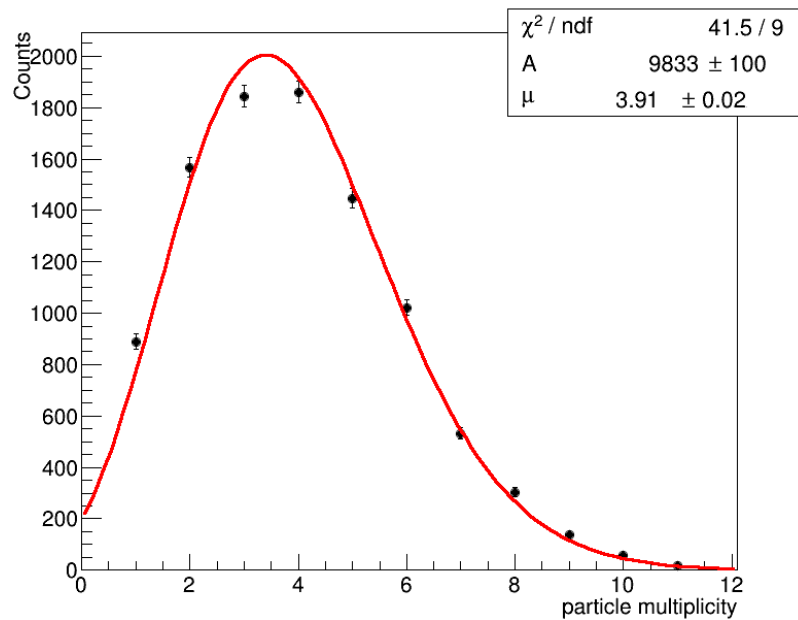
Digitized signals



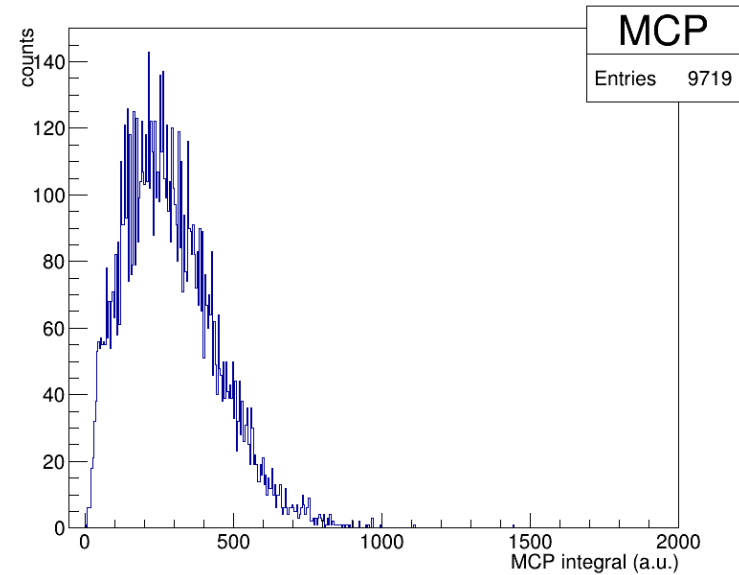
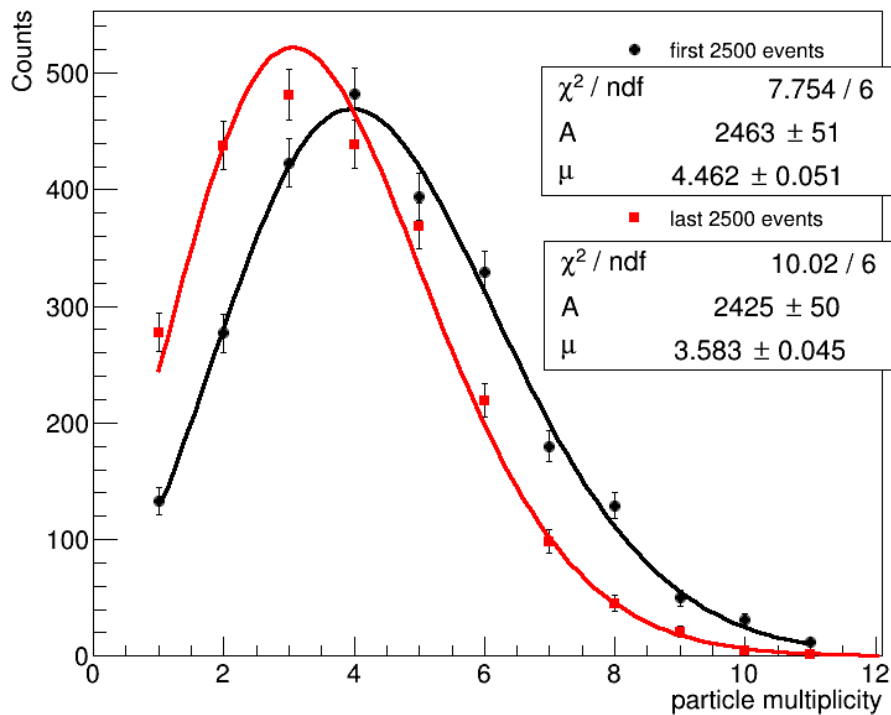
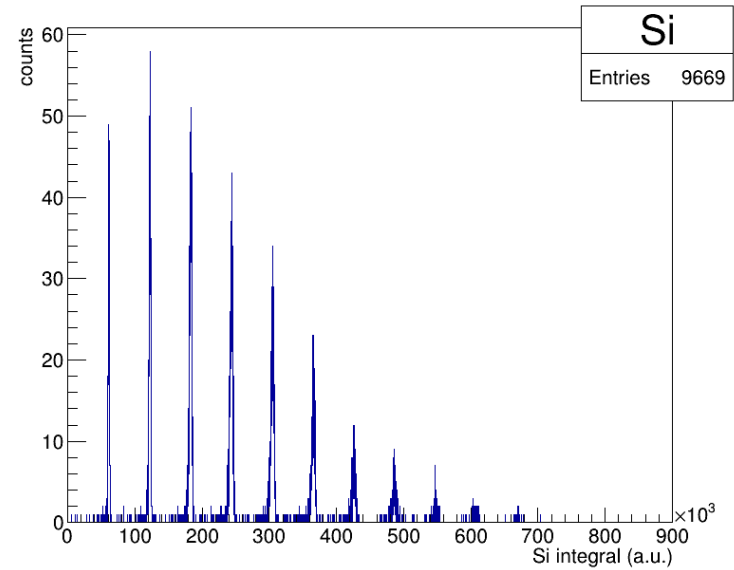
Preliminary measurements with different ions

10 MeV $^{12}\text{C}^{3+}$
10000 events @ 20 Hz





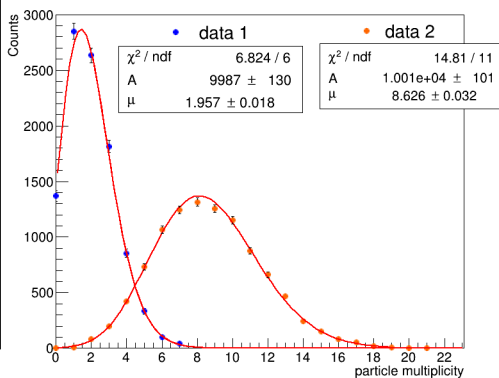
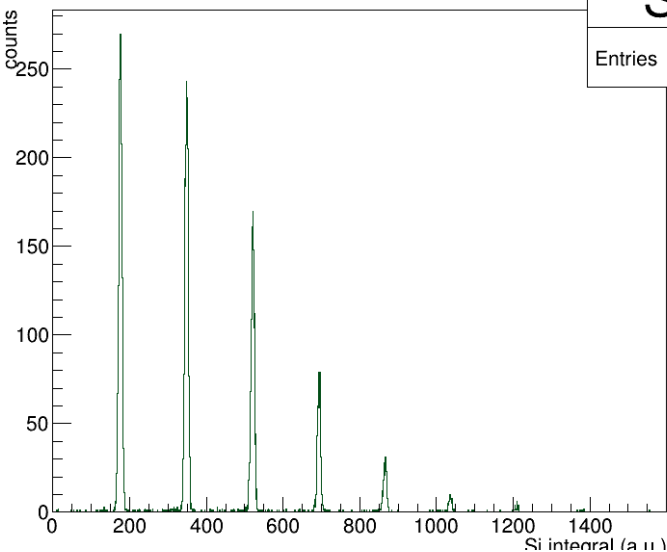
10 MeV $^{16}\text{O}^{4+}$
10000 events @ 20 Hz



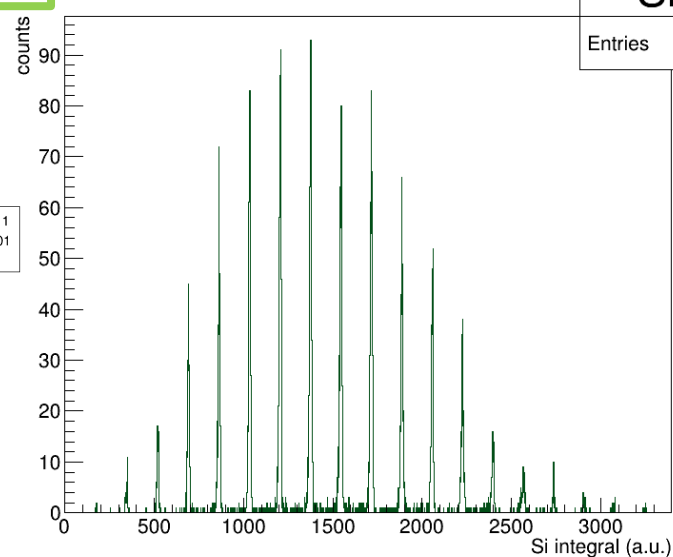
Preliminary measurements with different ions

**7.5 MeV ${}^7\text{Li}^{2+}$
10000 events @ 20Hz**

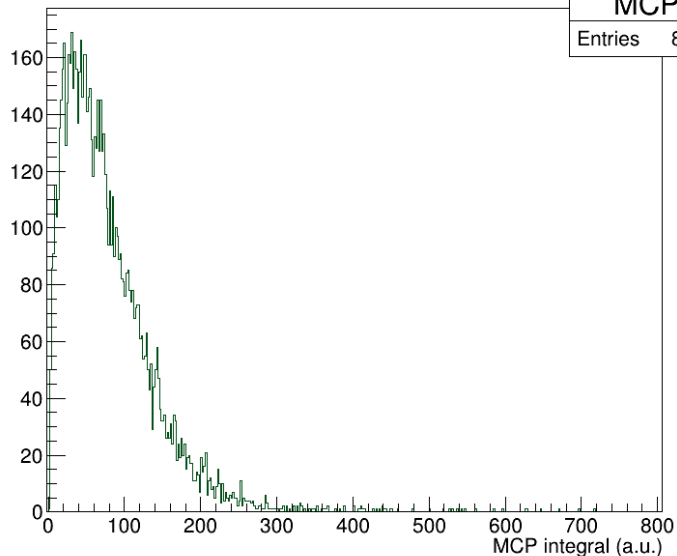
Si
Entries 8635



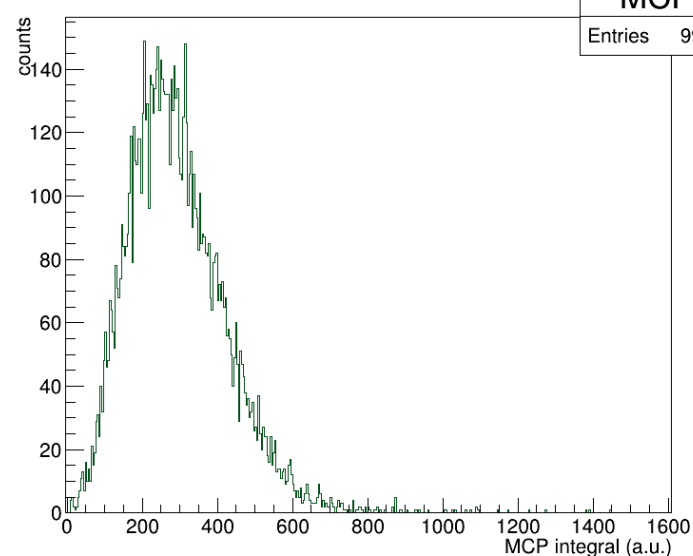
Si
Entries 9997



MCP
Entries 8599

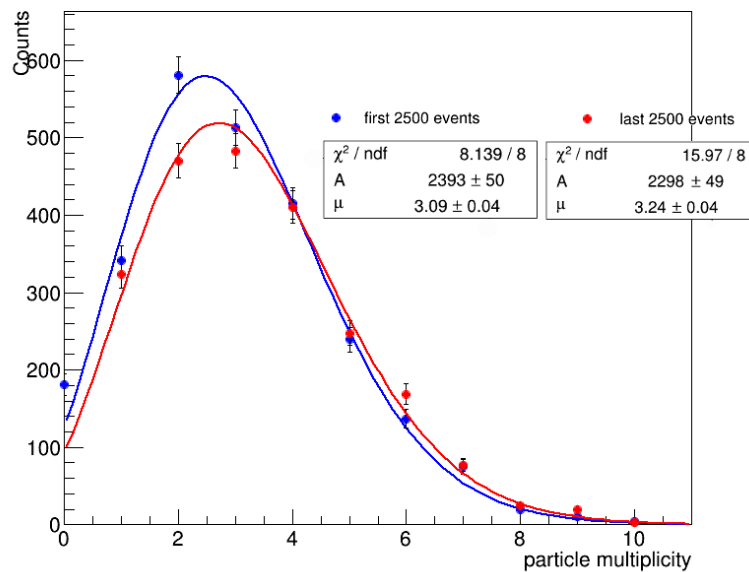
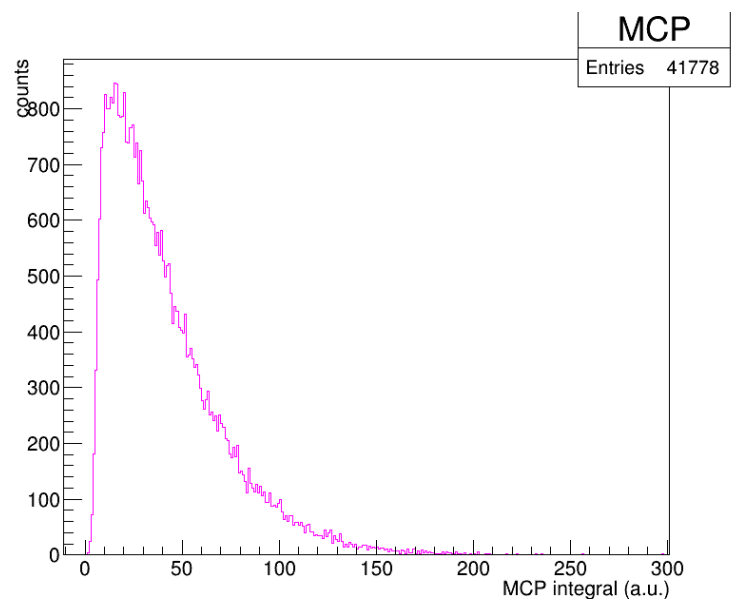
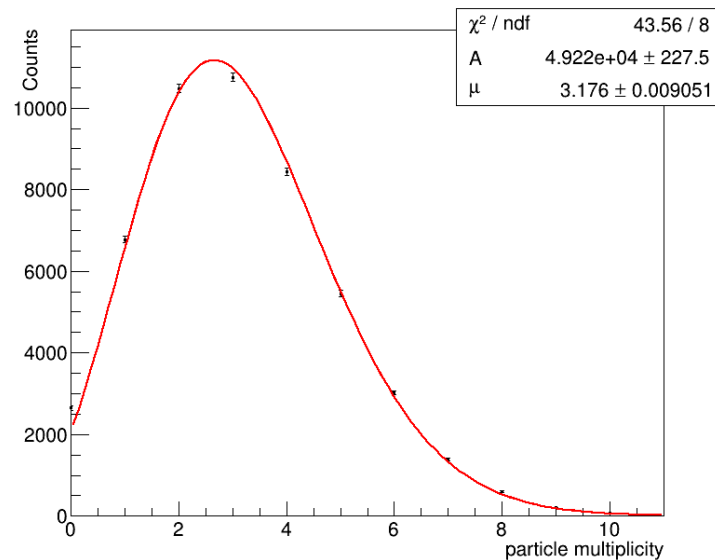
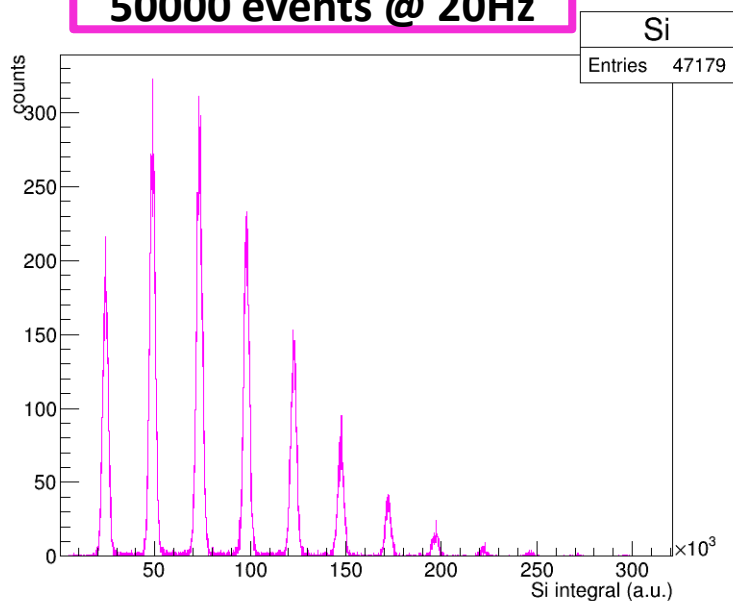


MCP
Entries 9997

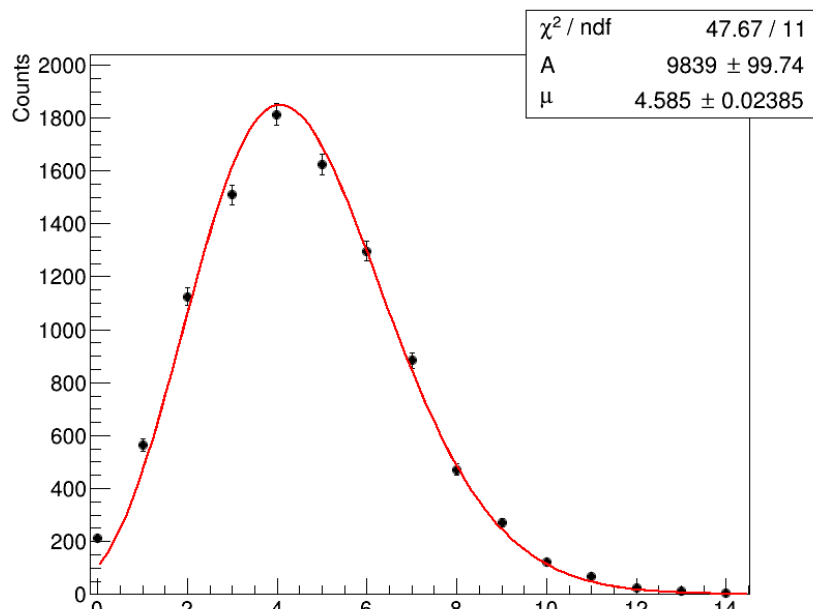


Preliminary measurements with different ions

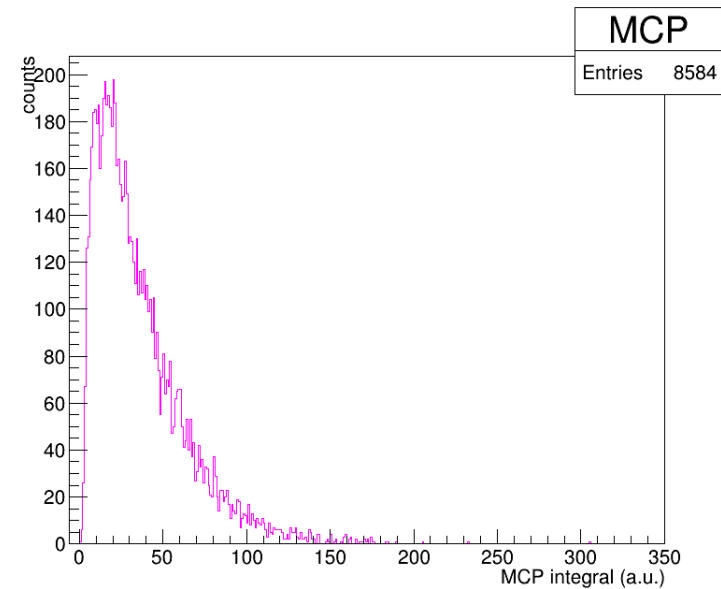
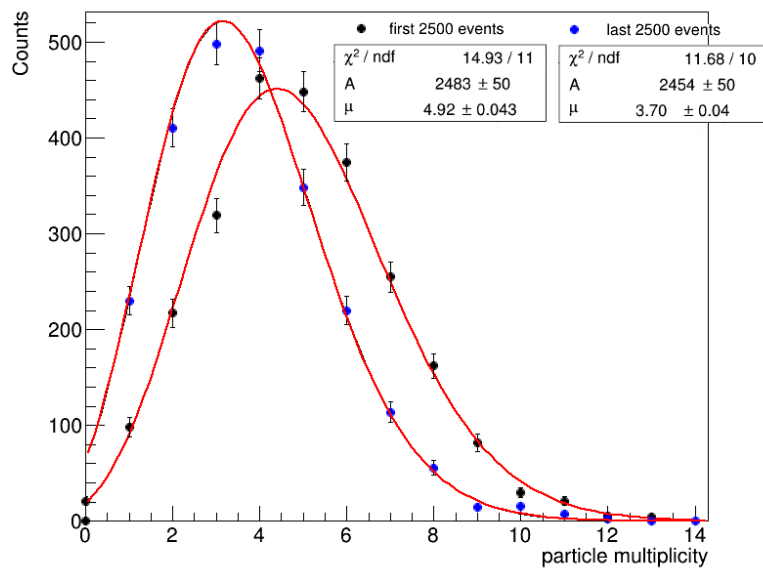
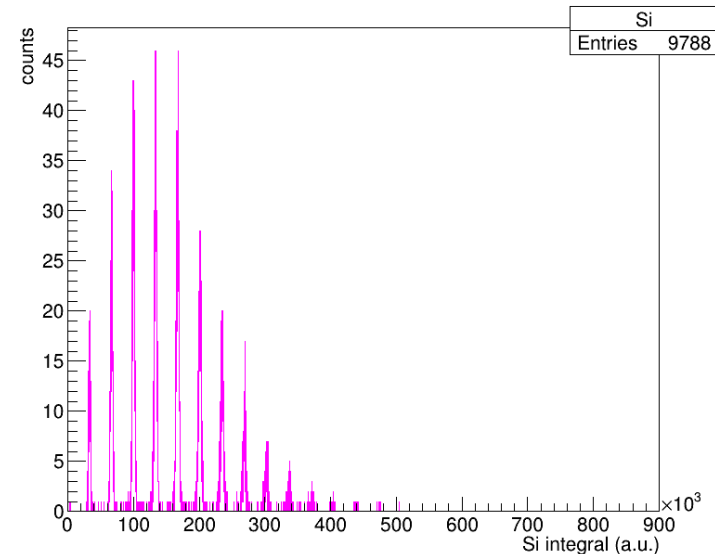
1.2 MeV H⁺
50000 events @ 20Hz



Preliminary measurements with different ions

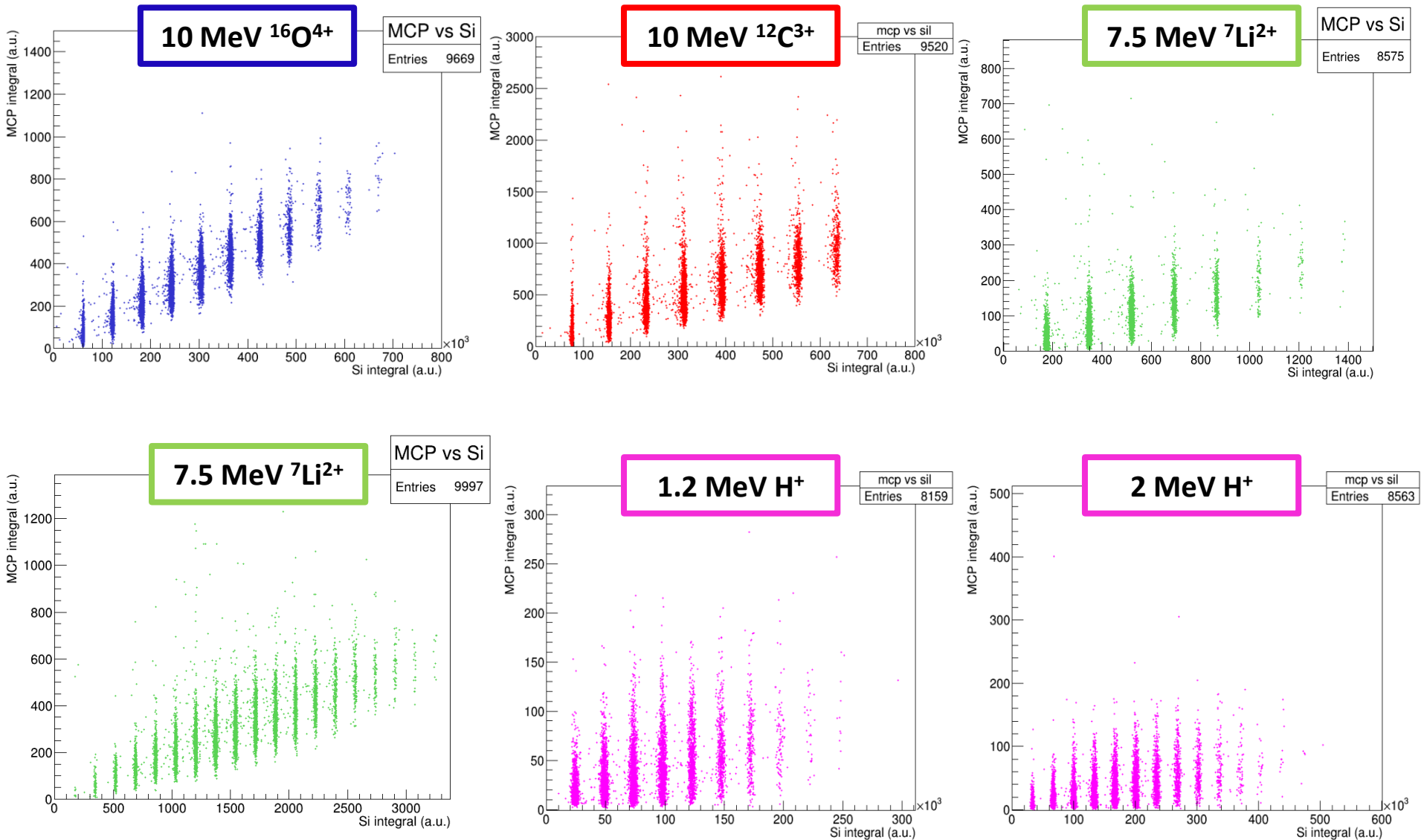


2 MeV H⁺
10000 events @ 20Hz



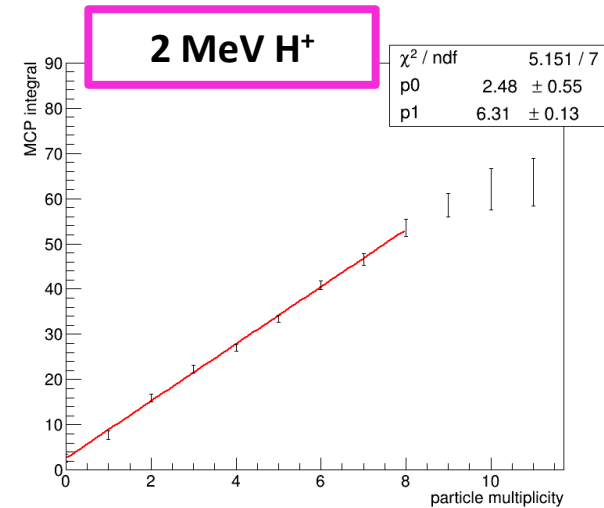
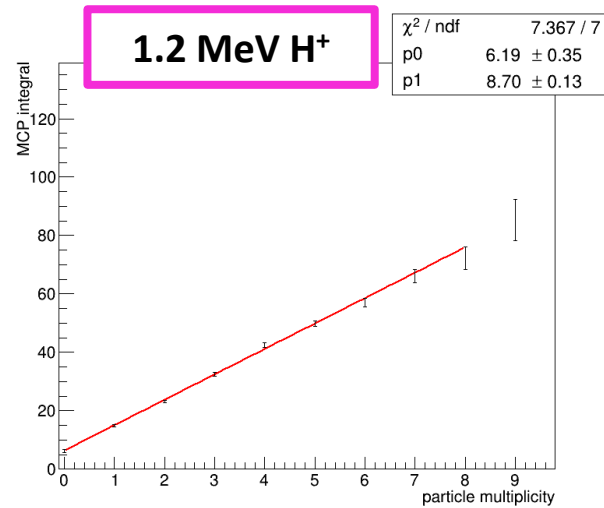
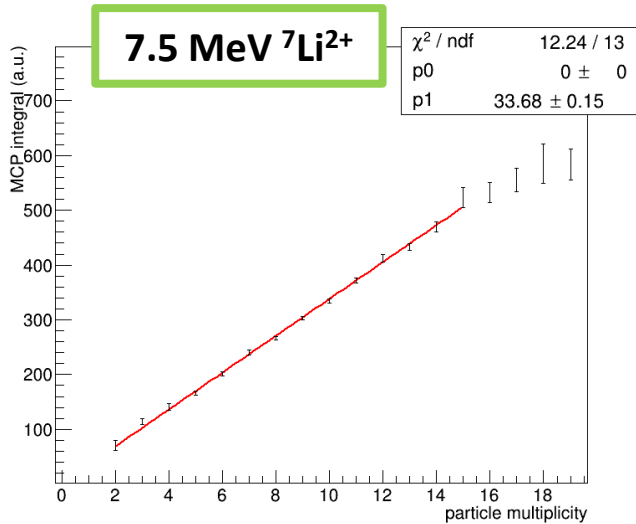
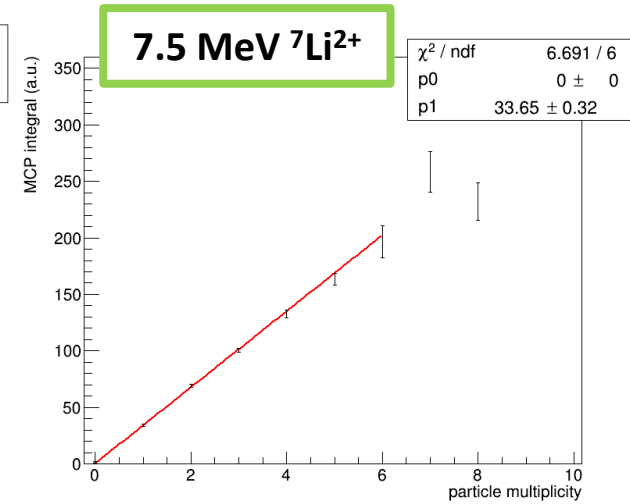
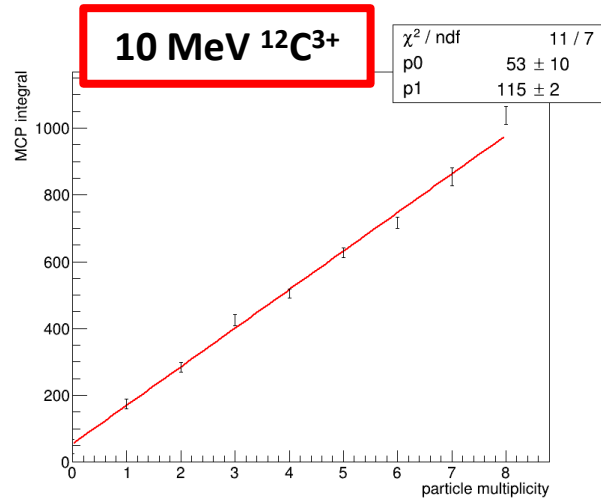
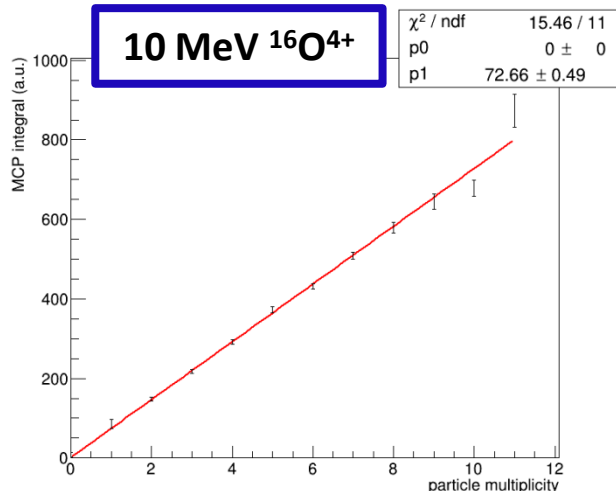
Detector system: calibration

MCP Integrals as a function of Si Integrals

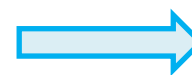


Detector system: calibration

Calibration curves



Average value of total MCP integral spectra



average multiplicity

Detector system: calibration results

μSi from Poisson fit

μMCP from integral spectra after calibration

(Delivered dose = ($\mu MCP \times N^\circ \text{events}$) $\times E$)

10 MeV $^{16}O^{4+}$	μSi	μMCP	$\frac{(\mu MCP - \mu Si)}{\mu Si}$
evts 0-2500(CAL)	4.46(21) \pm 0.05	4.46(24) \pm 0.08	+0.007%
evts 2500-5000	3.76 \pm 0.05	3.79 \pm 0.07	+0.8%
evts 5000-7500	3.73 \pm 0.05	3.71 \pm 0.07	-0.5%
evts 7500-10000	3.58 \pm 0.05	3.54 \pm 0.06	-1.1%

10 MeV $^{12}C^{3+}$	μSi	μMCP	$\frac{(\mu MCP - \mu Si)}{\mu Si}$
evts 0-2500(CAL)	4.38(0) \pm 0.05	4.37(8) \pm 0.095	-0.05%
evts 2500-5000	4.39(3) \pm 0.05	4.3(91) \pm 0.1	-0.035%
evts 5000-7500	4.17(2) \pm 0.05	4.1(96) \pm 0.1	+0.6%
evts 7500-10000	4.09(8) \pm 0.05	4.0(76) \pm 0.1	-0.54%
TEST	1.64(7) \pm 0.04	1.3(68) \pm 0.1	-17%

7.5 MeV $^7Li^{2+}$ (data 1)	μSi	μMCP	$\frac{(\mu MCP - \mu Si)}{\mu Si}$
evts 0-2500(CAL)	1.95(1) \pm 0.03	1.96(5) \pm 0.05	+0.7%
evts 2500-5000	2.00 \pm 0.02	2.04 \pm 0.05	+2%
evts 5000-7500	1.99 \pm 0.02	2.03(6) \pm 0.05	+2%
evts 7500-10000	1.88 \pm 0.02	1.93(0) \pm 0.05	+2.7%

7.5 MeV $^7Li^{2+}$ (data 2)	μSi	μMCP	$\frac{(\mu MCP - \mu Si)}{\mu Si}$
evts 0-2500(CAL)	8.81(3) \pm 0.07	8.8(53) \pm 0.1	+0.45%
evts 2500-5000	8.72(6) \pm 0.07	8.8(65) \pm 0.1	+1.6%
evts 5000-7500	8.63(8) \pm 0.07	8.6(37) \pm 0.1	-0.013%
evts 7500-10000	8.32(8) \pm 0.06	8.4(48) \pm 0.1	+1.4%

TEST: 60% decrease in average multiplicity with respect to the first dat set

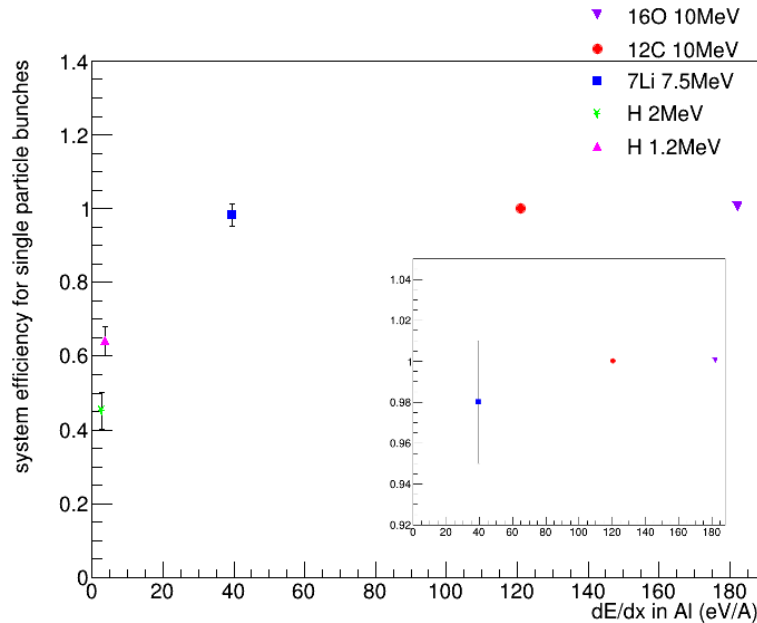
2 MeV H^+	μSi	μMCP	$\frac{(\mu MCP - \mu Si)}{\mu Si}$
evts 0-2500(CAL)	4.92(0) \pm 0.03	4.9(06) \pm 0.1	-0.3%
evts 2500-5000	4.96(7) \pm 0.03	4.9(36) \pm 0.1	-0.6%
evts 5000-7500	4.63(9) \pm 0.03	4.6(28) \pm 0.1	-0.2%
evts 7500-10000	3.67 \pm 0.04	3.48(7) \pm 0.09	-5%

25% decrease in average multiplicity with respect to the first dat set

1.2 MeV H^+	μSi	μMCP	$\frac{(\mu MCP - \mu Si)}{\mu Si}$
evts 0-10000(CAL)	3.05(8) \pm 0.03	3.04(3) \pm 0.05	-0.5%
evts 10000-20000	3.10(2) \pm 0.02	3.11 \pm 0.06	-0.27%
evts 20000-30000	3.23(9) \pm 0.02	3.34(8) \pm 0.06	+3%
evts 30000-40000	3.24(3) \pm 0.03	3.26(1) \pm 0.05	+0.55%
evts 40000-50000	3.20(9) \pm 0.02	3.29(7) \pm 0.07	+2.8%

Possible problems

With protons and with Li ions the foil-MCP system detection efficiency is reduced



Work with bunches of multiplicity ≥ 5

Some ion may not hit the Si detector if it leaves the foil with a large angle

Ion	$P_{loss}(distance10cm)$	$P_{loss}(distance15cm)$	$P_{loss}(distance2.5cm)$
^{16}O (10 MeV)	2.54%	7.63%	0.0009%
^{12}C (10 MeV)	1%	2.6%	0.0005%
7Li (7.5 MeV)	0.3%	0.6%	0.0002%
H (1.2 MeV)	0.8%	2.2%	0.001%
H (2 MeV)	0.4%	0.7%	0.0002%

Reduce foil thickness
Minimize foil-Si distance

Conclusions and future work

- New series of test measurements will be performed to test and optimize the calibration procedure
- Upgrade of the system to allow for on-line determination of particle fluence and for monitoring possible beam current variations.
- The first irradiations with quartz samples will be carried out with the new system. Samples must be irradiated with known and uniform doses